


<b>Search Notes</b>  	<b>Application/Control No.</b>  10576989	<b>Applicant(s)/Patent Under Reexamination</b>  VANDYNE ET AL.
	<b>Examiner</b>  HIEU T VO	<b>Art Unit</b>  3747

SEARCHED			
Class	Subclass	Date	Examiner
123	435, 568.21, 406.21, 406.23, 406.44	12/5/2009	HV
73	35.08, 116, 117.3	12/5/2009	HV
701	101, 102, 108, 109	12/5/2009	HV

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	12/5/2009	HV

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	All of above	12/5/2009	HV

	/HIEU T VO/ Primary Examiner.Art Unit 3747
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